GRM Series Specifications and Test Methods (2)

lo.	Ite	em	Specifications	Test Method			
1	Operating Temperat Range		B1, B3, F1: -25 to +85°C R1, R7, C7, D7, E7: -55 to +125°C C6, R6: -55 to +85°C F5: -30 to +85°C C8, D8: -55 to +105°C,	Reference temperature: 25°C (B1, B3, R1, F1: 20°C)			
2	Rated Voltage		See the previous pages.	The rated voltage is defined as the maximum voltage which may be applied continuously to the capacitor. When AC voltage is superimposed on DC voltage, V ^{p,p} or V ^{o,p} , whichever is larger, should be maintained within the rated voltage range.			
3	Appearance		No defects or abnormalities	Visual inspection			
4	Dimensio	ns	Within the specified dimensions	Using calipers			
5	Dielectric Strength		No defects or abnormalities	No failure should be observed when 250% of the rated voltage is applied between the terminations for 1 to 5 seconds, provided the charge/discharge current is less than 50mA.			
6	Insulation Resistance		More than $50\Omega \cdot F$	The insulation resistance should be measured with a DC voltage not exceeding the rated voltage at reference temperature and 75%RH max. and within 1 minutes of charging, provided the charge/discharge current is less than 50mA.			
7	Capacitance		*Table 1 GRM155 B3/R6 1A 124 to 105 GRM185 B3/R6 1C/1A 105 GRM185 C8/D7 1A 105 GRM188 B3/R6 1C/1A 225 GRM188 B3/R6 1A 335 GRM219 B3/R6 1C/1A 475, 106 GRM219 C8 1A 475 GRM21B B3/R6 1C/1A 106 GRM21B R7/C8 1A 106 GRM319 B3/R6 1C/1A 106	The capacitance/D.F. should be measured at reference temperature at the frequency and voltage shown in the table. $\begin{tabular}{ c c c c c } \hline Capacitance & Frequency & Voltage \\ \hline C\leq 10\mu F (10V min.)^{*1} & 1\pm 0.1 kHz & 1.0\pm 0.2 Vrms \\ \hline C\leq 10\mu F (6.3V max.) & 1\pm 0.1 kHz & 0.5\pm 0.1 Vrms \\ \hline C>10\mu F & 120\pm 24 Hz & 0.5\pm 0.1 Vrms \\ \hline *1 & However the voltage is 0.5\pm 0.1 Vrms about Table 1 \\ items on the left side. \end{tabular}$			
8	Dissipatio (D.F.)	n Factor	B1, B3, R6* ² , R7* ³ , C7, C8, D8* ² : 0.1 max. F1, F5: 0.2 max.				
		No bias	$\begin{array}{rl} B1, B3: Within \pm 10\% (-25 \ to +85^{\circ}{\rm C}) \\ F1 & : Within \pm 30/-80\% (-25 \ to +85^{\circ}{\rm C}) \\ R6 & : Within \pm 15\% (-55 \ to +85^{\circ}{\rm C}) \\ R1, R7: Within \pm 15\% (-55 \ to +125^{\circ}{\rm C}) \\ F5 & : Within \pm 22/-82\% (-30 \ to +85^{\circ}{\rm C}) \\ C6 & : Within \pm 22\% (-55 \ to +85^{\circ}{\rm C}) \\ C7 & : Within \pm 22\% (-55 \ to +125^{\circ}{\rm C}) \\ C8 & : Within \pm 22\% (-55 \ to +105^{\circ}{\rm C}) \\ D7 & : Within \pm 22/-33\% (-55 \ to +125^{\circ}{\rm C}) \\ E7 & : Within \pm 22/-56\% (-55 \ to +125^{\circ}{\rm C}) \end{array}$	The capacitance change should be measured after 5 min. at each specified temp. stage. The ranges of capacitance change compared with the reference temperature value over the temperature ranges shown in the table should be within the specified ranges.* In case of applying voltage, the capacitance change should be measured after 1 more min. with applying voltage in equilibration of each temp. stage. *GRM43 B1/R6 0J/1A 336/476 only: 1.0±0.2Vrms			
			D8 : Within +22/-33% (-55 to +105℃)	Step Temperature (°C) Applying Voltage (V			
				1 25±2 (for R6, R7, C6, C7, C8, D7, D8, E7, F5) 20±2 (for B1, B3, F1, R1)			
				-55±3 (for R1, R6, R7, C6, C7, C8, D7, D8, E7) -30±3 (for F5) -25±3 (for B1, B3, F1)			
9				3 25±2 (for R6, R7, C6, C7, C8, D7, D8, E7, F5) 20±2 (for B1, B3, F1, R1)			
		50% of	Rated R1: Within +15/-40%	125±3 (for R1, R7, C7, D7, E7) 4 105±3 (for C8, D8) 85±3 (for B1, B3, F1, F5, R6, C6)			
		the Rated Voltage		$ \begin{array}{ c c c c c c } \hline 5 & 20 \pm 2 \ (\text{for B1}, F1, R1) \\ \hline & -55 \pm 3 \ (\text{for R1}) \\ -25 \pm 3 \ (\text{for B1}, F1) \\ \hline & 7 & 20 \pm 2 \ (\text{for B1}, F1, R1) \\ \hline & 405 \pm 2 \ (\text{for B1}, F1, R1) \\ \hline \end{array} $			
				8 125±3 (for R1) 85±3 (for B1, F1)			
				 Initial measurement for high dielectric constant type Perform a heat treatment at 150 +0/-10°C for one hour and then set for 24±2 hours at room temperature. Perform the initial measurement. 			

*2: GRM31CR60J107, GRM31CD80G107: 0.15 max. *3: GRM31CR71E106: 0.125 max.



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No	lte	em	Specifications	Test Method			
	Adhesive Strength of Termination		No removal of the terminations or other defects should occur.	Solder the capacitor on the test jig (glass epoxy board) shown in Fig. 1a using an eutectic solder. Then apply 10N* force in parallel with the test jig for 10±1sec. The soldering should be done either with an iron or using the reflow method and should be conducted with care so that the soldering is uniform and free of defects such as heat shock. *1N: GRM02, 2N: GRM03, 5N: GRM15/GRM18			
10			Solder resist Baked electrode or copper foil	Type GRM02 GRM03 GRM15 GRM18 GRM21 GRM31 GRM32 GRM43 GRM55	a 0.2 0.3 0.4 1.0 1.2 2.2 3.5 4.5	b 0.56 0.9 1.5 3.0 4.0 5.0 5.0 7.0 8.0	c 0.23 0.3 0.5 1.2 1.65 2.0 2.9 3.7 5.6
		Appearance	No defects or abnormalities	Solder the capacitor on the test jig (glass epoxy board) in the			
		Capacitance	Within the specified tolerance	same manner and	-		-
11	Vibration	D.F.	B1, B3, R1, R6* ² , R7* ³ , C7, C8, E7, D7, D8* ² : 0.1 max. C6: 0.125 max. F1, F5: 0.2 max.	The capacitor should be subjected to a simple harmonic motion having a total amplitude of 1.5mm, the frequency being varied uniformly between the approximate limits of 10 and 55Hz. The frequency range, from 10 to 55Hz and return to 10Hz, should be traversed in approximately 1 minute. This motion should be applied for a period of 2 hours in each of 3 mutually perpendicular directions (total of 6 hours).			
12	Deflection		No cracking or marking defects should occur.	Solder the capacit in Fig. 2a using an direction shown in done by the reflow so that the solderin shock.	eutectic solde Fig. 3a for 5± method and s	r. Then apply a I sec. The sold hould be cond hod free of defe	a force in the lering should be ucted with care
	Solderability of Termination			(in mm) Immerse the capacitor in a solution of ethanol (JIS-K-8101) and rosin (JIS-K-5902) (25% rosin in weight proportion) . Preheat at 80 to 120°c for 10 to 30 seconds. After preheating, immerse in an eutectic solder solution for 2±0.5 seconds at 230±5°c or Sn-3.0Ag-0.5Cu solder solution for 2±0.5 seconds at 245±5°C.			

*2: GRM31CR60J107, GRM31CD80G107: 0.15 max.

*3: GRM31CR71E106: 0.125 max.

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No.	Ite	em	Specifications	Test Method					
14	Resistance to Soldering Heat	Appearance Capacitance Change	No defects or abnormalities B1, B3, R1, R6*4, R7, C6, C7, C8, E7, D7, D8: Within ±7.5% F1, F5: Within ±20%	 Preheat the capacitor at 120 to 150°C for 1 minute. Immerse the capacitor in an eutectic solder or Sn-3.0Ag-0.5Cu solder solution at 270±5°C for 10±0.5 seconds. Set at room temperature for 24±2 hours, then measure. *Do not apply to GRM02. Initial measurement for high dielectric constant type 					
		D.F.	B1, B3, R1, R6* ² , R7* ³ , C7, C8, E7, D7, D8* ² : 0.1 max. C6: 0.125 max. F1, F5: 0.2 max.						
		I.R.	More than $50\Omega \cdot F$	Perform a heat treatment at 150+0/-10°C for one hour and then set at room temperature for 24±2 hours. Perform the initial measurement.				ur and	
		Dielectric Strength	No defects	*Preheating for GRM32/43/55					
				<u>Step</u> 1 2	Temperature Time 100 to 120°C 1 min 170 to 200°C 1 min			nin.	
		Appearance	No defects or abnormalities		he capacitor to the supporting jig in the same manner a				
15	Temperature Sudden Change	Capacitance Change	B1, B3, R1, R6, R7, C6, C7, C8, D7, D8: Within ±7.5% E7: Within ±30% F1, F5: Within ±20%	 under the same conditions as (10). Perform the five cycles according to the four heat treatments shown in the following table. Set for 24±2 hours at room temperature, then measure. 					
		D.F.	B1, B3, R1, R6* ² , R7* ³ , C7, C8, E7, D7, D8* ² : 0.1 max. C6: 0.125 max. F1, F5: 0.2 max.	Step	1 Min.	2	3 Max.	4	
		I.R.	More than $50\Omega \cdot F$	Temp. (°C)	Operating Temp. +0/-3	Room Temp.	Operating Temp. +3/-0	Room Temp.	
		Dielectric Strength	No defects	Time (min.) 30 ± 3 2 to 3 30 ± 3 2 to 3 •Initial measurement for high dielectric constant typePerform a heat treatment at $150+0/-10^{\circ}$ for one hour andthen set at room temperature for 24 ± 2 hours.Perform the initial measurement.					
		Appearance	No defects or abnormalities		-		d 90 to 95% hur	-	
16	High Temperature High Humidity (Steady)	Capacitance Change	B1, B3, R1, R6, R7, C6, C7, C8, E7, D7, D8: Within ±12.5% F1, F5: Within ±30%	 500±12 hours. The charge/discharge current is less than 50mA Initial measurement Perform a heat treatment at 150+0/-10°C for one hour and then let sit for 24±2 hours at room temperature. Perform the initial measurement. 					
		D.F.	B1, B3, R1, R6, R7, C6, C7, C8, E7, D7, D8: 0.2 max. F1, F5: 0.4 max.						
		I.R.	More than 12.5 Ω · F	 Measurement after test Perform a heat treatment at 150+0/−10°C for one hour and then let sit for 24±2 hours at room temperature, then measure. 					
17	Durability	Appearance	No defects or abnormalities	Apply 150% of the rated voltage for 1000±12 hours at the maximum operating temperature ±3°C. Let sit for 24±2 hours at room temperature, then measure. The charge/discharge current is less than 50mA.					
		Capacitance Change	B1, B3, R1, R6, R7, C6, C7, C8, E7, D7, D8: Within ±12.5% F1, F5: Within ±30%						
		D.F.	B1, B3, R1, R6, R7, C6, C7, C8, E7, D7, D8: 0.2 max. F1, F5: 0.4 max.						
		I.R.	More than $25\Omega\cdot F$	 Perform a heat treatment at 150+0/-10°C for one hour and then let sit for 24±2 hours at room temperature. Perform the initial measurement. Measurement after test Perform a heat treatment at 150+0/-10°C for one hour and then let sit for 24±2 hours at room temperature, then measurement 				orm the ur and	

*2: GRM31CR60J107, GRM31CD80G107: 0.15 max.

*3: GRM31CR71E106: 0.125 max. *4: GRM153R60G105, GRM188R60J106: Within ±12.5%

